

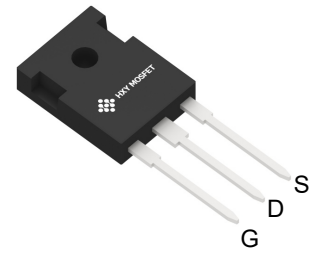


Features

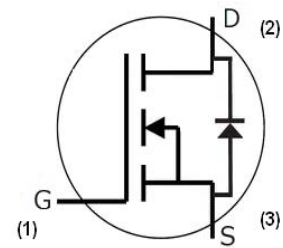
- High Blocking Voltage with Low On-Resistance
- Temperature-Independent switching behavior
- Highoperatingjunctiontemperaturecapability

Applications

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC converters
- Online UPS/Industrial UPS



TO-247



Part Number	Package	Qty(PCS)
UF3C065040K3S	TO-247	30

Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	650	V	$V_{GS} = 0\text{ V}$, $I_D = 1\text{ mA}$	
V_{GSmax}	Gate - Source Voltage	-8/+22	V	Absolute Maximum Values	
V_{GSop}	Gate - Source Voltage	-4/+15	V	Recommended operational values	
I_D	Continuous Drain Current	85	A	$V_{GS} = 15\text{ V}$, $T_c = 25^\circ\text{C}$	Fig. 19
		60		$V_{GS} = 15\text{ V}$, $T_c = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	160	A	Pulse width t_p limited by T_{jmax}	Fig. 22
P_D	Power Dissipation	312	W	$T_c = 25^\circ\text{C}$, $T_J = 1^\circ\text{C}$	Fig. 20
T_J, T_{stg}	Operating Junction and Storage Temperature	-55 to +175	$^\circ\text{C}$		
T_L	Solder Temperature	260	$^\circ\text{C}$	1.6mm (0.063") from case for 10s	



Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Value			Unit	Note
			Min	Typ	Max		
$V_{(BR)DSS}$	Drain Source Breakdown Voltage	$V_{GS}=0V, I_D=1mA$	650	-	-	V	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=10mA$	1.8	2.9	4.3	V	Fig.11
		$V_{DS}=V_{GS}, I_D=10mA, T_J=175^\circ\text{C}$	-	2.1	-	V	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=650V, V_{GS}=0V$		0.02	10	μA	
I_{GSS}	Gate Source Leakage Current	$V_{GS}=15V, V_{DS}=0V$	-	-	100	nA	
$R_{DS(on)}$	Current Drain-Source On-State Resistance	$V_{GS}=15V, I_D=30A$	-	38	51	m Ω	Fig.4,5,6
		$V_{GS}=15V, I_D=30A, T_J=175^\circ\text{C}$	-	44	-		
		$V_{GS}=18V, I_D=30A$	-	28	41		
		$V_{GS}=18V, I_D=30A, T_J=175^\circ\text{C}$	-	40	-		
g_{fs}	Transconductance	$V_{DS}=20V, I_D=30A$	-	18	-	S	Fig.7
		$V_{DS}=20V, I_D=30A, T_J=175^\circ\text{C}$	-	17	-		
$R_{g,int}$	Internal Gate Resistance	$V_{AC}=25mV, f=1MHz$	-	8.3	-	Ω	
V_{SD}	Diode Forward Voltage	$V_{GS}=-4V, I_{SD}=15A$	-	3.2	-	V	Fig.8,9,10
		$V_{GS}=-4V, I_{SD}=15A, T_J=175^\circ\text{C}$	-	2.8	-		

Reverse Diode Characteristics

Symbol	Parameter	Conditions	Value			Unit	Note
			Min	Typ	Max		
C_{iss}	Input Capacitance	$V_{DS}=600V, V_{GS}=0V, T_J=25^\circ\text{C}, V_{AC}=25mV, f=100KHz$	-	2682	-	pF	Fig.17, 18
C_{oss}	Output Capacitance		-	246	-		
C_{rss}	Reverse Capacitance		-	12	-		
E_{oss}	Coss Stored Energy		-	46	-	μJ	Fig.16
Q_{gs}	Gate Source Charge	$V_{DS}=400V, V_{GS}=-4/15V, I_D=30A$	-	22	-	nC	Fig.12
Q_{gd}	Gate Drain Charge		-	32	-		
Q_g	Gate Charge		-	103	-		



Switching Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Value			Unit	Note
			Min	Typ	Max		
E_{on}	Turn on Switching Energy	$V_{DS}=400V, V_{GS}=-4/+15V, I_D=30A,$ $R_g=2.5\Omega, L=120\mu H$	-	341	-	μJ	Fig.23
E_{off}	Turn off Switching Energy		-	62	-		
$t_{d(on)}$	Turn on Delay Time		-	54	-	nS	Fig.27
t_r	Rise Time		-	25	-		
$t_{d(off)}$	Turn off Delay Time		-	35	-		
t_f	Fall Time		-	13	-		

Body Diode Characteristics

Symbol	Parameter	Conditions	Value			Unit	Note
			Min	Typ	Max		
V_{SD}	Diode Forward Voltage	$V_{GS} = -4V, I_{SD}=15A$	-	3.2	-	V	Fig.8,9,10
		$V_{GS} = -4V, I_{SD}=15A, T_J=175^\circ\text{C}$	-	2.8	-		
t_{rr}	Reverse Recovery Time	$VR=400V, V_{GS} = -4V, I_D=30A,$ $di/dt=1000A/\mu S$	-	18	-	nS	
Q_{rr}	Reverse Recovery Charge		-	108	-	nC	
I_{rm}	Peak Reverse Recovery Current		-	10	-	A	

Thermal Characteristics

Symbol	Parameter	Conditions	Value	Unit	Note
$R_{th(j-c)}$	Thermal Resistance from Junction to Case		0.48	$^\circ\text{C/W}$	Fig.21



Typical Performance

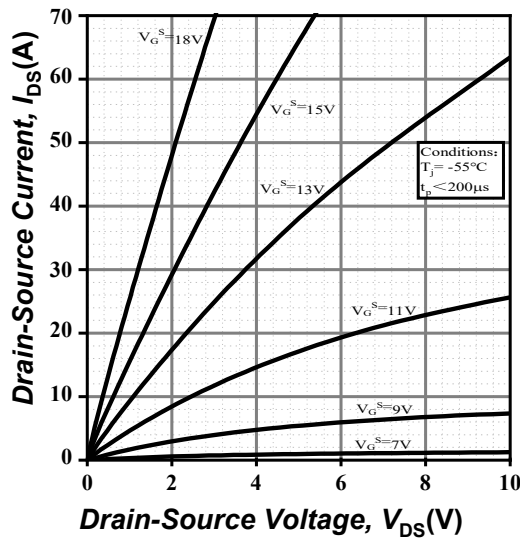


Figure 1. Output Characteristic $T_j = -55^\circ\text{C}$

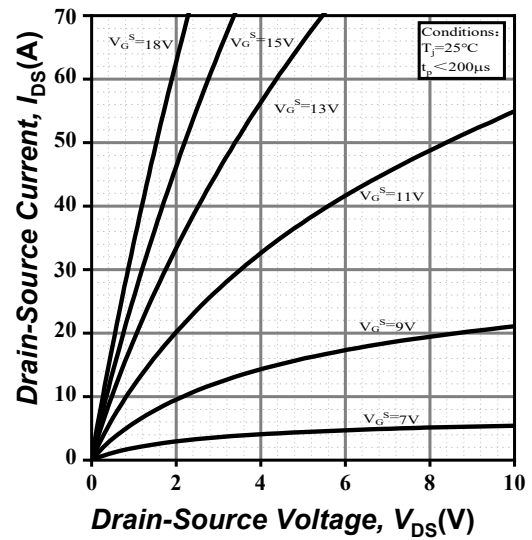


Figure 2. Output Characteristic $T_j = 25^\circ\text{C}$

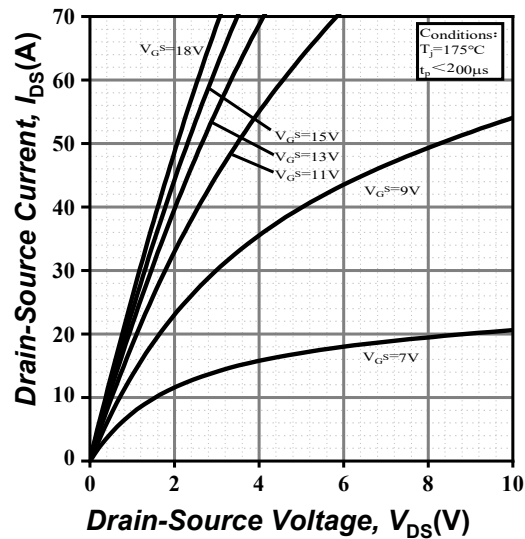


Figure 3. Output Characteristic $T_j = 175^\circ\text{C}$

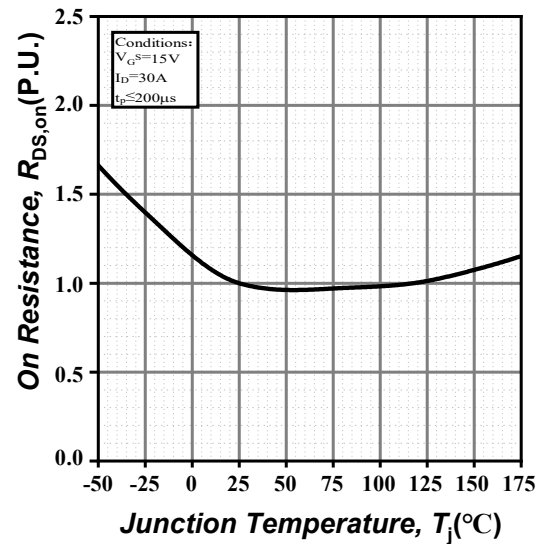


Figure 4. Normalized On-Resistance vs. Temperature

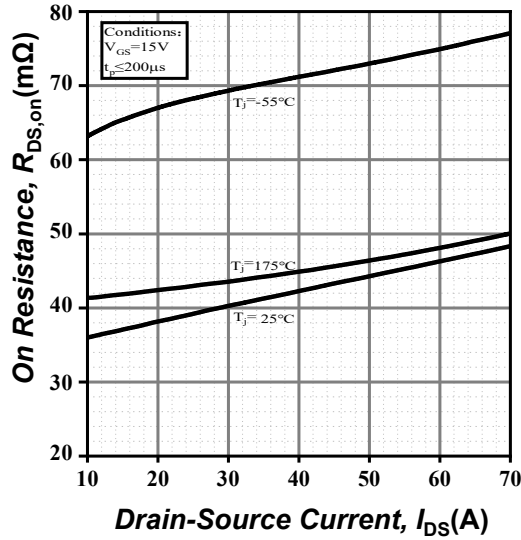


Figure 5. On-Resistance vs. Drain Current for Various Temperature

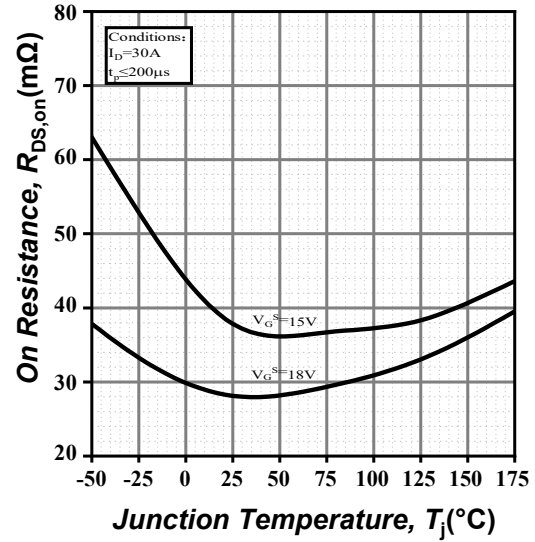


Figure 6. On-Resistance vs. Temperature for Various Gate Voltage

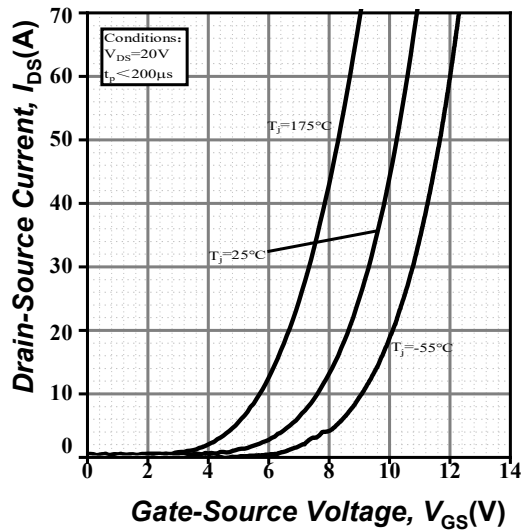


Figure 7. Transfer Characteristic for Various Junction Temperature

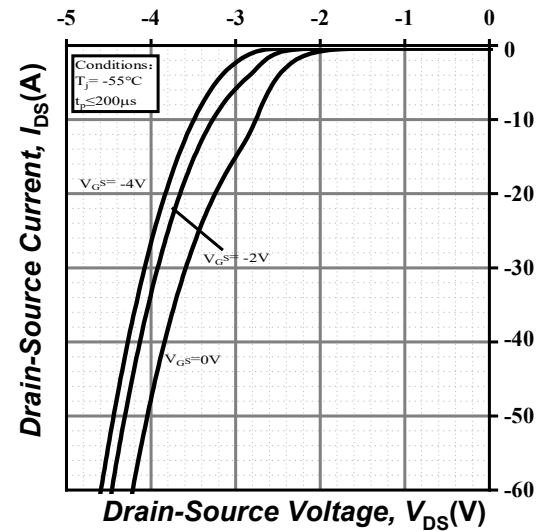


Figure 8. Body Diode Characteristic $T_j = -55^\circ\text{C}$

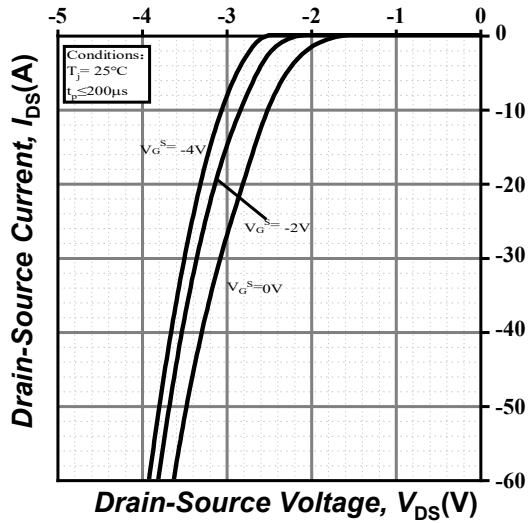


Figure 9. Body Diode Characteristic $T_j = 25^\circ\text{C}$

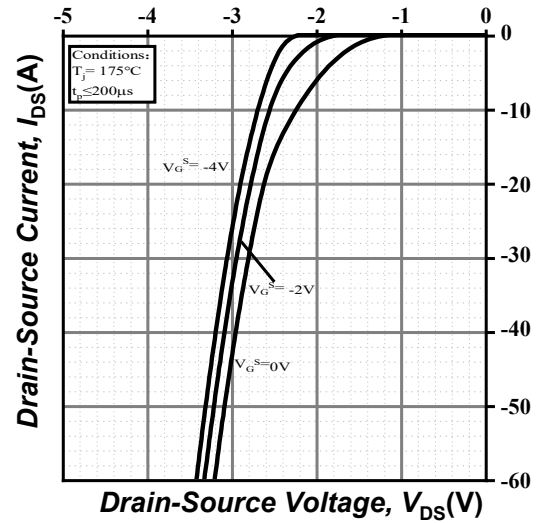


Figure 10. Body Diode Characteristic $T_j = 175^\circ\text{C}$

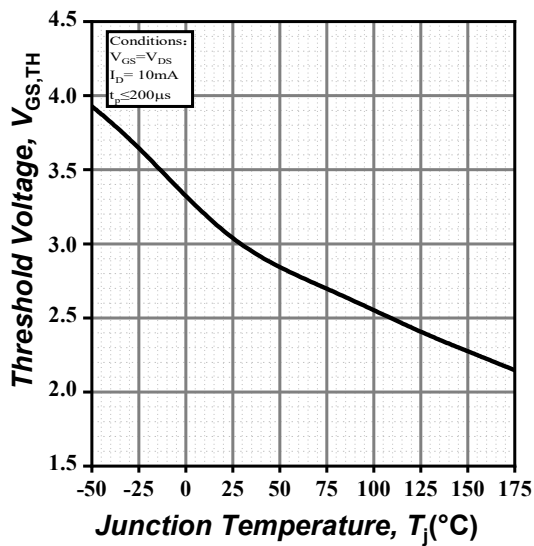


Figure 11. Threshold Voltage vs. Temperature

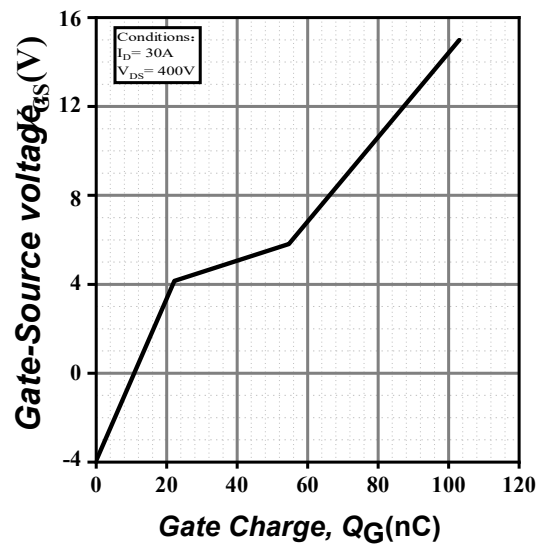


Figure 12. Gate Charge Characteristic

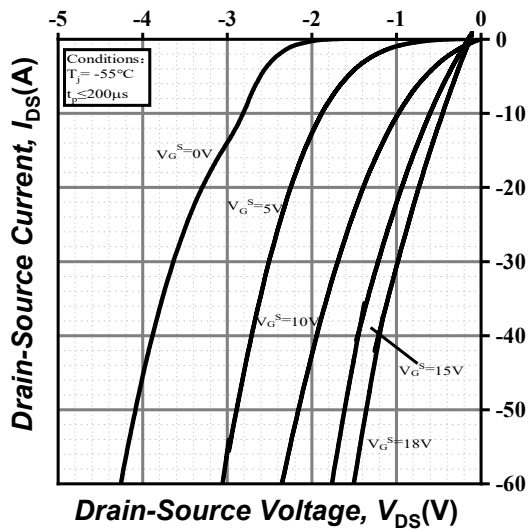


Figure 13. 3rd Quadrant Characteristic $T_j = -55^\circ\text{C}$

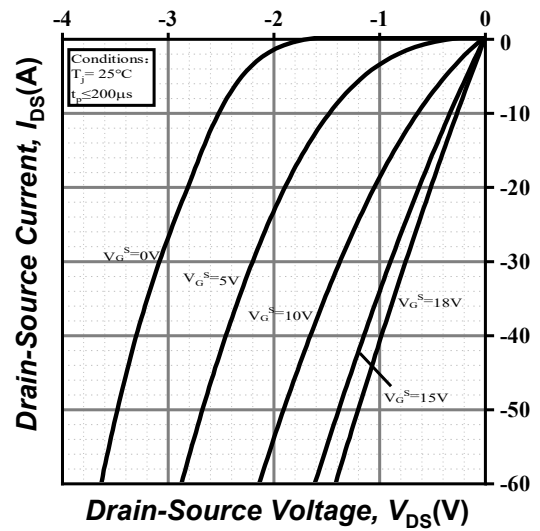


Figure 14. 3rd Quadrant Characteristic $T_j = 25^\circ\text{C}$

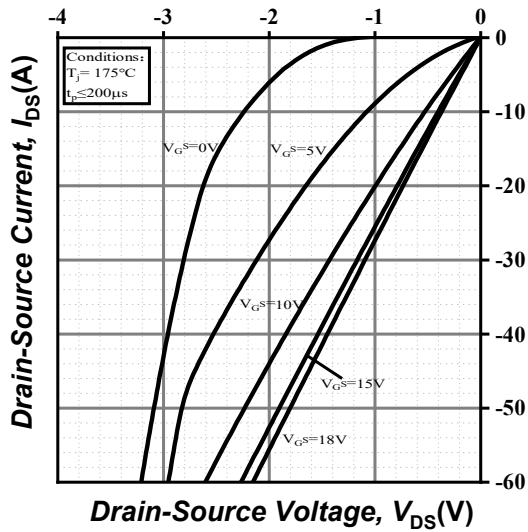


Figure 15. 3rd Quadrant Characteristic $T_j = 175^\circ\text{C}$

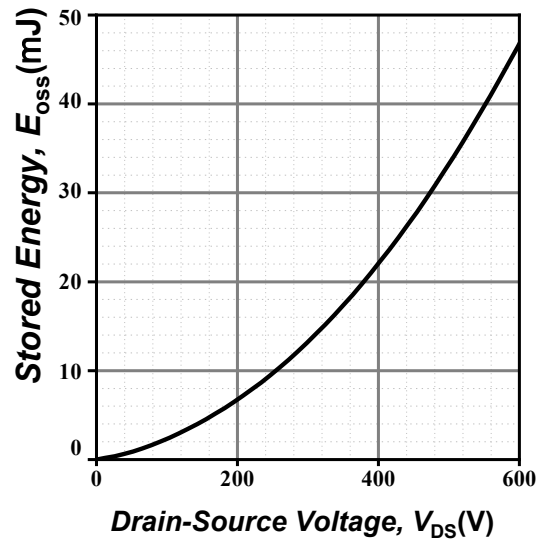


Figure 16. Output Capacitor Stored Energy

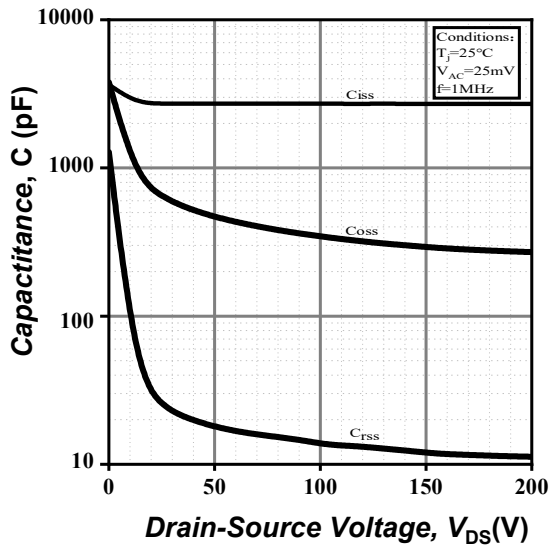


Figure 17. Capacitance vs. Drain-Source Voltage(0 - 200V)

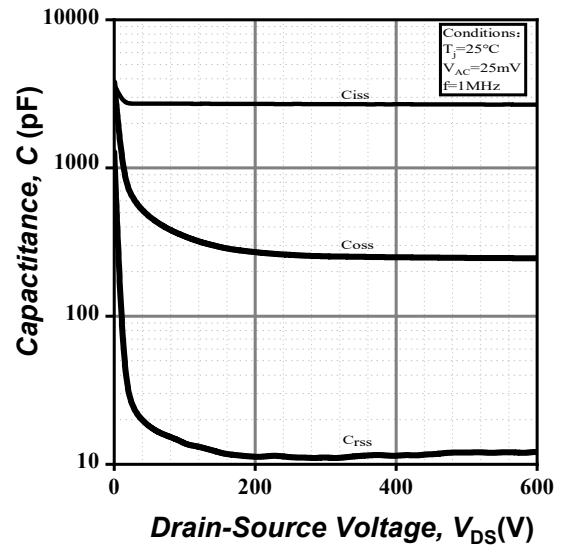


Figure 18. Capacitance vs. Drain-Source Voltage(0 - 600V)

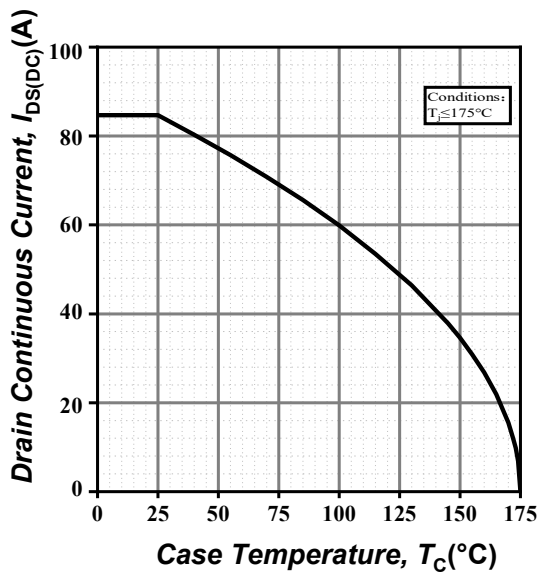


Figure 19. Continuous Drain Current Derating vs. Case Temperature

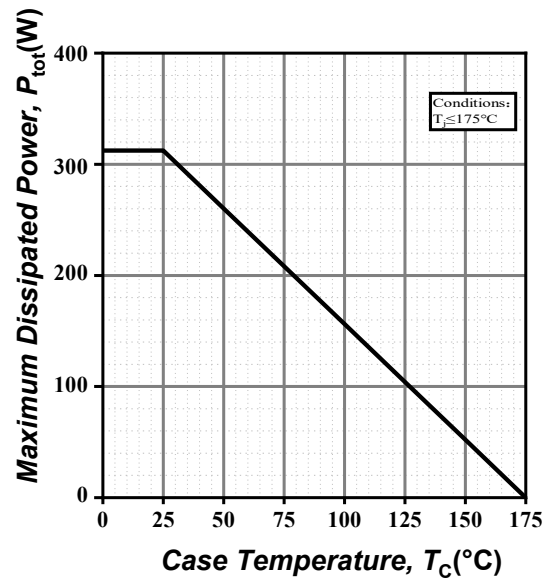


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

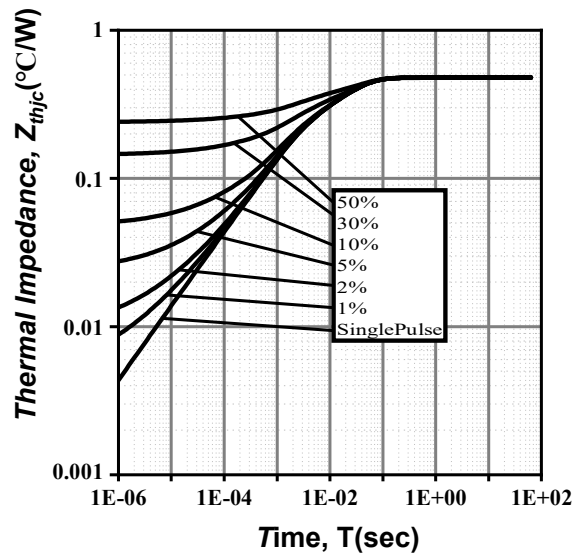


Figure 21. Transient Thermal Impedance
(Junction - Case)

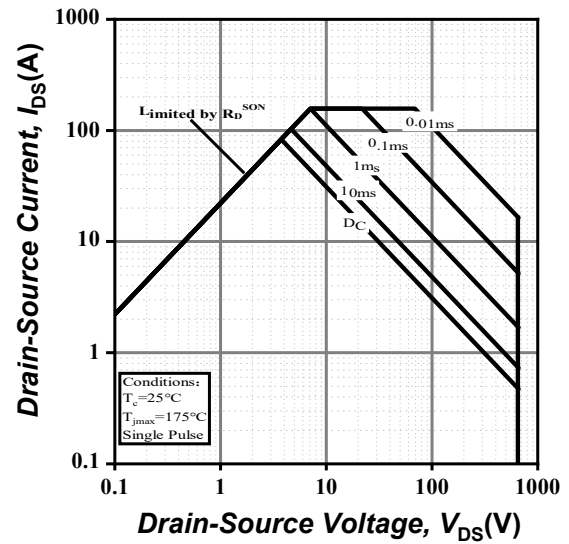


Figure 22. Safe Operation Area

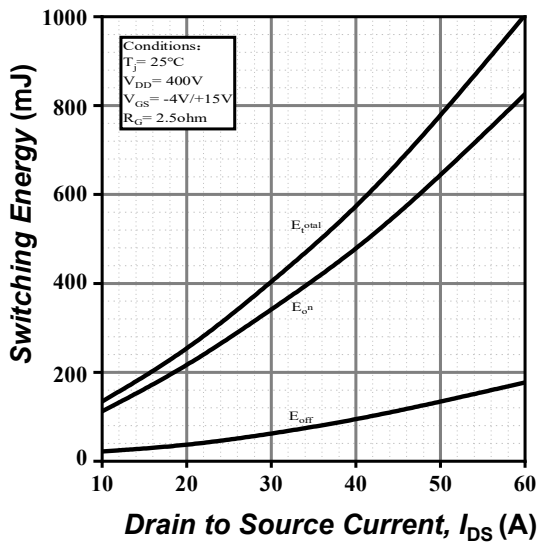


Figure 23. Clamped Inductive Switching Energy
vs. Drain Current($V_{DD}=400V$)

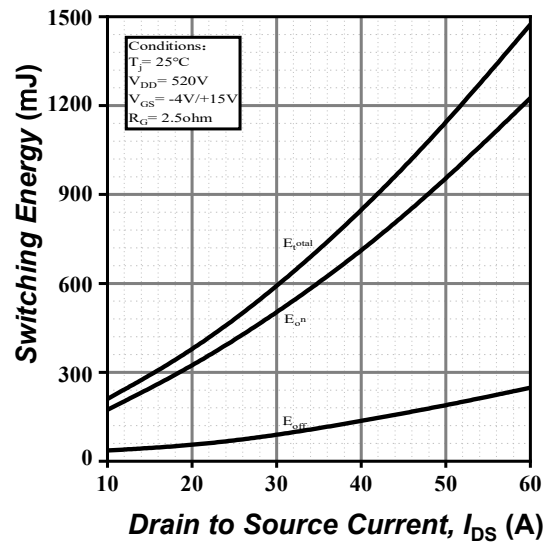


Figure 24. Clamped Inductive Switching Energy
vs. Drain Current($V_{DD}=520V$)

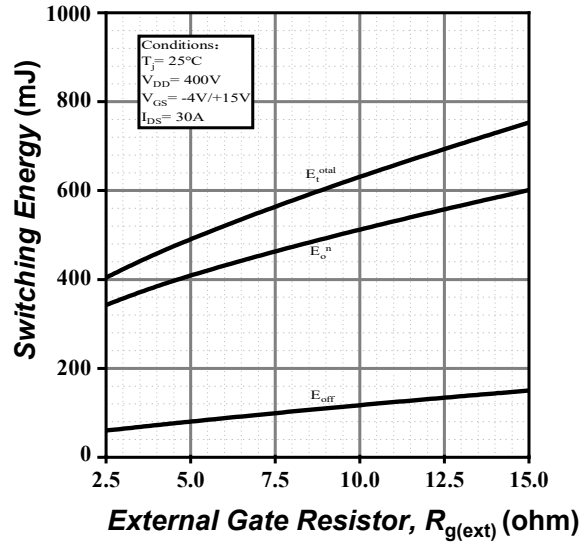


Figure 25. Clamped Inductive Switching Energy vs. $R_{g(ext)}$

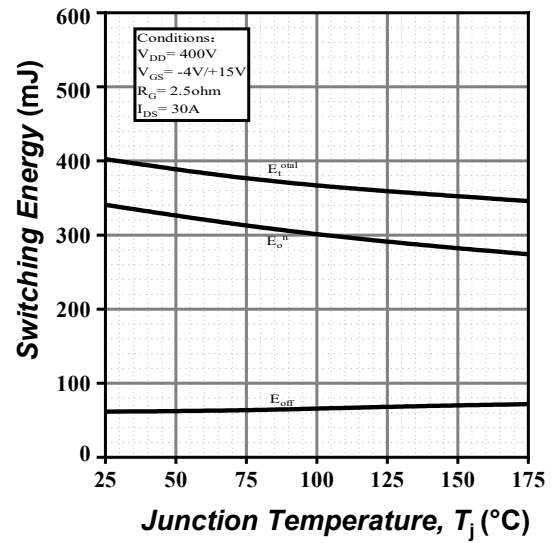


Figure 26. Clamped Inductive Switching Energy vs. Temperature

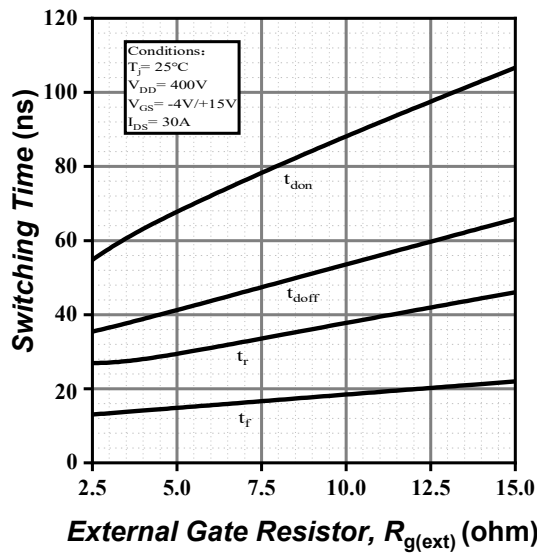
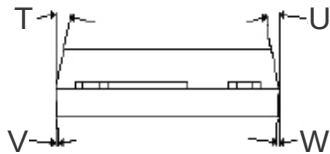
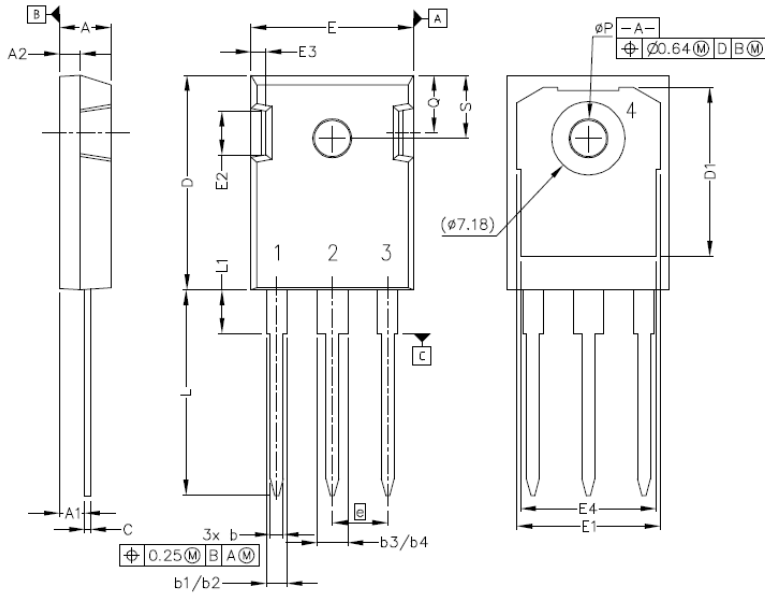


Figure 27. Switching Times vs. $R_{g(ext)}$



Package Dimensions

Package TO-247

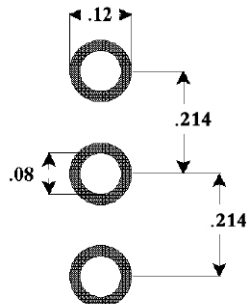


Pinout Information:

- Pin 1 = Gate
- Pin 2, 4 = Drain
- Pin 3 = Source

POS	Inches		Millimeters	
	Min	Max	Min	Max
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.042	.052	1.07	1.33
b1	.075	.095	1.91	2.41
b2	.075	.085	1.91	2.16
b3	.113	.133	2.87	3.38
b4	.113	.123	2.87	3.13
c	.022	.027	0.55	0.68
D	.819	.831	20.80	21.10
D1	.640	.695	16.25	17.65
D2	.037	.049	0.95	1.25
E	.620	.635	15.75	16.13
E1	.516	.557	13.10	14.15
E2	.145	.201	3.68	5.10
E3	.039	.075	1.00	1.90
E4	.487	.529	12.38	13.43
e	.214 BSC		5.44 BSC	
N	3		3	
L	.780	.800	19.81	20.32
L1	.161	.173	4.10	4.40
ØP	.138	.144	3.51	3.65
Q	.216	.236	5.49	6.00
S	.238	.248	6.04	6.30
T	9°	11°	9°	11°
U	9°	11°	9°	11°
V	2°	8°	2°	8°
W	2°	8°	2°	8°

Recommended Solder Pad Layout



TO247-3L



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